

**Notice of References Cited**

Application/Control No.

09/615,021

Applicant(s)/Patent Under

Reexamination

PHILLIPS ET AL.

Examiner

Narayanswamy Subramanian

Art Unit

3695

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-7,072,863	07-2006	Phillips et al.	705/36R
*	B US-6,606,615	08-2003	Jennings et al.	706/45
*	C US-5,812,988	09-1998	Sandretto, Michael J.	705/36R
*	D US-5,960,415	09-1999	Williams, Geoff	705/30
*	E US-6,473,084	10-2002	Phillips et al.	345/440
*	F US-6,658,467	12-2003	Rice et al.	709/224
*	G US-6,792,399	09-2004	Phillips et al.	705/36R
*	H US-6,125,355	09-2000	Bekaert et al.	705/36R
*	I US-6,456,982	09-2002	Pilipovic, Dragana N.	705/36R
*	J US-5,361,201	11-1994	Jost et al.	705/35
*	K US-6,609,109	08-2003	Bradley et al.	705/35
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	EP 1107157 A2	06-2001	FRANCE	PAVILLON, C	---
O	JP 2007264939 A	10-2007	JAPAN	SHINBA et al.	---
P	JP 2008046835 A	02-2008	JAPAN	SHINBA et al.	---
Q	WO 03/096254	05-2003	USA	MARKOV et al.	---
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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